Search Notes

Application/C	ontrol No.	Applicant(s)/Patent Reexamination	under
10/644,604		WALSH ET AL.	
Examiner		Art Unit	
Anthony Wei	er	1761	

SEARCHED					
Class	Subclass	Date	Examiner		
426	583, 656, 516, 465, 468	5/11/2006	AW		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search	5/11/2006	AW		
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